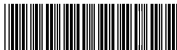


Search Notes**Application/Control No.**

10/767,250

**Applicant(s)/Patent under
Reexamination**

TIEDEMANN ET AL.

Examiner

AFSAR M. QURESHI

Art Unit

2416

SEARCHED

Class	Subclass	Date	Examiner
370	209,311 320,335- 338,342	10/21/2008	AQ
375	130,135	10/21/2008	AQ
455	455,522	10/21/2008	AQ
455	436-439	10/21/2008	AQ

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST, WEST,IEEE,USPAT,EPO	10/21/2008	AQ
Consulted with SPE (112 1 st)	10/21/2008	AQ